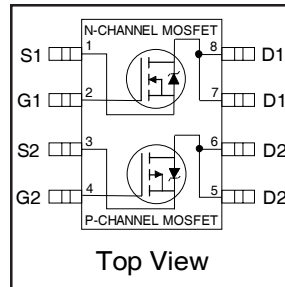


# IRF7507PbF

HEXFET® Power MOSFET

- Generation V Technology
- Ultra Low On-Resistance
- Dual N and P Channel MOSFET
- Very Small SOIC Package
- Low Profile (<1.1mm)
- Available in Tape & Reel
- Fast Switching
- Lead-Free

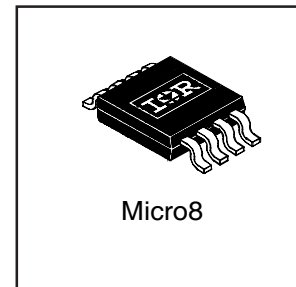


	N-Ch	P-Ch
$V_{DS}$	20V	-20V
$R_{DS(on)}$	0.135 $\Omega$	0.27 $\Omega$

## Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The new Micro8 package, with half the footprint area of the standard SO-8, provides the smallest footprint available in an SOIC outline. This makes the Micro8 an ideal device for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro8 will allow it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards.



## Absolute Maximum Ratings

	Parameter	Max.		Units
		N-Channel	P-Channel	
$V_{DS}$	Drain-Source Voltage	20	-20	V
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS}$	2.4	-1.7	A
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS}$	1.9	-1.4	A
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	19	-14	A
$P_D @ T_A = 25^\circ\text{C}$	Maximum Power Dissipation <sup>④</sup>	1.25		W
$P_D @ T_A = 70^\circ\text{C}$	Maximum Power Dissipation <sup>④</sup>	0.8		W
	Linear Derating Factor	10		mW/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 12$		V
$V_{GSM}$	Gate-to-Source Voltage Single Pulse $t_p < 10\mu\text{s}$	16		V
$dv/dt$	Peak Diode Recovery $dv/dt$ <sup>②</sup>	5.0	-5.0	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to + 150		°C
	Soldering Temperature, for 10 seconds	240 (1.6mm from case)		

## Thermal Resistance

	Parameter	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient <sup>④</sup>	100	°C/W

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

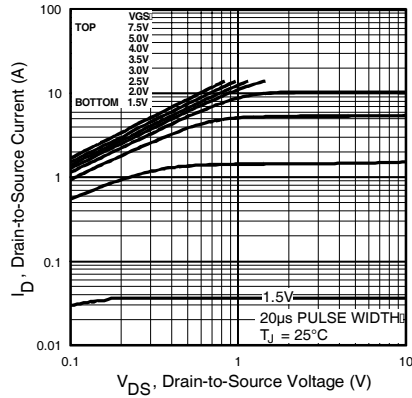
	Parameter		Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	N-Ch	20	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
		P-Ch	-20	—	—		$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	N-Ch	—	0.041	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
		P-Ch	—	-0.012	—		Reference to $25^\circ\text{C}$ , $I_D = -1\text{mA}$
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance	N-Ch	—	0.085	0.14	$\Omega$	$V_{GS} = 4.5V, I_D = 1.7A$ ③
			—	0.120	0.20		$V_{GS} = 2.7V, I_D = 0.85A$ ③
			—	0.17	0.27		$V_{GS} = -4.5V, I_D = -1.2A$ ③
		P-Ch	—	0.28	0.40		$V_{GS} = -2.7V, I_D = -0.6A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	N-Ch	0.7	—	—	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
		P-Ch	-0.7	—	—		$V_{DS} = V_{GS}, I_D = -250\mu A$
$g_{fs}$	Forward Transconductance	N-Ch	2.6	—	—	S	$V_{DS} = 10V, I_D = 0.85A$ ③
		P-Ch	1.3	—	—		$V_{DS} = -10V, I_D = -0.6A$ ③
$I_{DSS}$	Drain-to-Source Leakage Current	N-Ch	—	—	1.0	$\mu A$	$V_{DS} = 16V, V_{GS} = 0V$
		P-Ch	—	—	-1.0		$V_{DS} = -16V, V_{GS} = 0V$
		N-Ch	—	—	25		$V_{DS} = 16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
		P-Ch	—	—	-25		$V_{DS} = -16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	N-P	—	—	$\pm 100$		$V_{GS} = \pm 12V$
$Q_g$	Total Gate Charge	N-Ch	—	5.3	8.0	nC	N-Channel $I_D = 1.7A, V_{DS} = 16V, V_{GS} = 4.5V$ ④
		P-Ch	—	5.4	8.2		
$Q_{gs}$	Gate-to-Source Charge	N-Ch	—	0.84	1.3		
		P-Ch	—	0.96	1.4		
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	N-Ch	—	2.2	3.3		P-Channel $I_D = -1.2A, V_{DS} = -16V, V_{GS} = -4.5V$
		P-Ch	—	2.4	3.6		
$t_{d(on)}$	Turn-On Delay Time	N-Ch	—	5.7	—	ns	N-Channel $V_{DD} = 10V, I_D = 1.7A, R_G = 6.0\Omega, R_D = 5.7\Omega$ ④
		P-Ch	—	9.1	—		
$t_r$	Rise Time	N-Ch	—	24	—		
		P-Ch	—	35	—		
$t_{d(off)}$	Turn-Off Delay Time	N-Ch	—	15	—		P-Channel $V_{DD} = -10V, I_D = -1.2A, R_G = 6.0\Omega, R_D = 8.3\Omega$ ④
		P-Ch	—	38	—		
$t_f$	Fall Time	N-Ch	—	16	—	pF	
		P-Ch	—	43	—		
$C_{iss}$	Input Capacitance	N-Ch	—	260	—		N-Channel $V_{GS} = 0V, V_{DS} = 15V, f = 1.0\text{MHz}$ ③
		P-Ch	—	240	—		
$C_{oss}$	Output Capacitance	N-Ch	—	130	—		
		P-Ch	—	130	—		
$C_{rss}$	Reverse Transfer Capacitance	N-Ch	—	61	—		P-Channel $V_{GS} = 0V, V_{DS} = -15V, f = 1.0\text{MHz}$
		P-Ch	—	64	—		

## Source-Drain Ratings and Characteristics

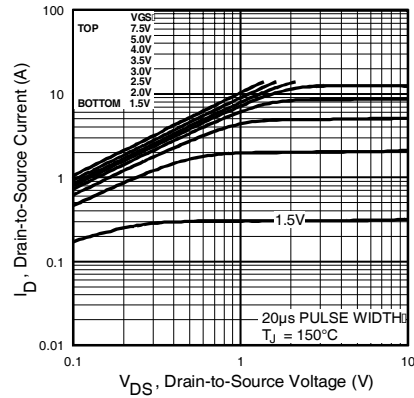
	Parameter		Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	N-Ch	—	—	1.25	A	
		P-Ch	—	—	-1.25		
$I_{SM}$	Pulsed Source Current (Body Diode) ①	N-Ch	—	—	19		
		P-Ch	—	—	-14		
$V_{SD}$	Diode Forward Voltage	N-Ch	—	—	1.2	V	$T_J = 25^\circ\text{C}, I_S = 1.7A, V_{GS} = 0V$ ③
		P-Ch	—	—	-1.2		$T_J = 25^\circ\text{C}, I_S = -1.2A, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time	N-Ch	—	39	59	ns	N-Channel $T_J = 25^\circ\text{C}, I_F = 1.7A, di/dt = 100A/\mu s$
		P-Ch	—	52	78		
$Q_{rr}$	Reverse Recovery Charge	N-Ch	—	37	56	nC	P-Channel $T_J = 25^\circ\text{C}, I_F = -1.2A, di/dt = -100A/\mu s$ ③
		P-Ch	—	63	95		

### Notes:

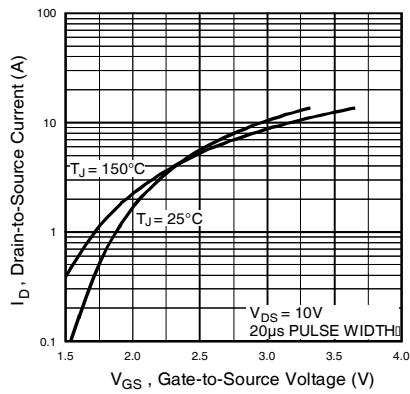
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 21 )
- ② N-Channel  $I_{SD} \leq 1.7A, di/dt \leq 66A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ\text{C}$   
P-Channel  $I_{SD} \leq -1.2A, di/dt \leq 100A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ\text{C}$
- ③ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .
- ④ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .



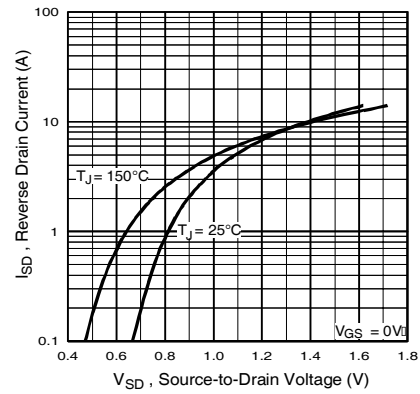
**Fig 1.** Typical Output Characteristics



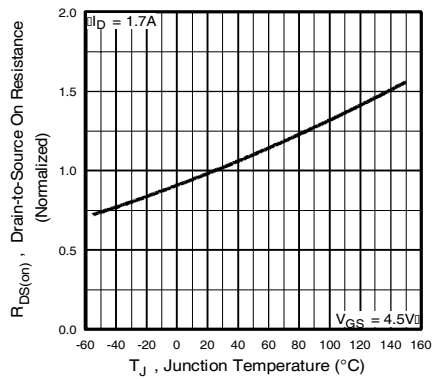
**Fig 2.** Typical Output Characteristics



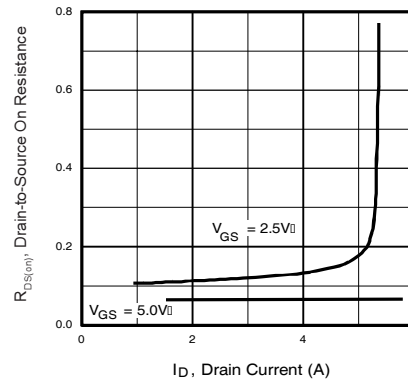
**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Typical Source-Drain Diode Forward Voltage



**Fig 5.** Normalized On-Resistance Vs. Temperature

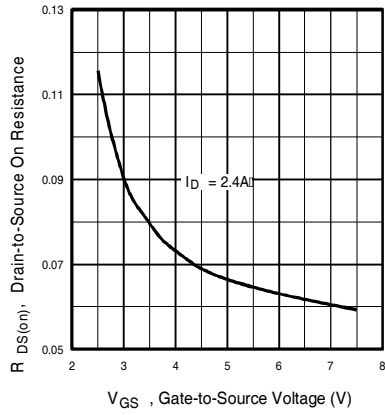


**Fig 6.** Typical On-Resistance Vs. Drain Current

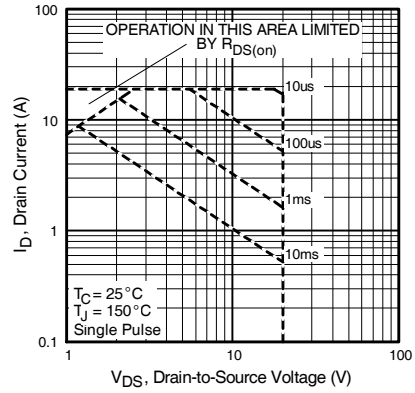
# IRF7507PbF

N - Channel

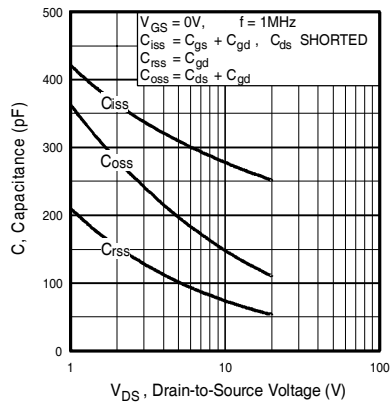
International  
**IR** Rectifier



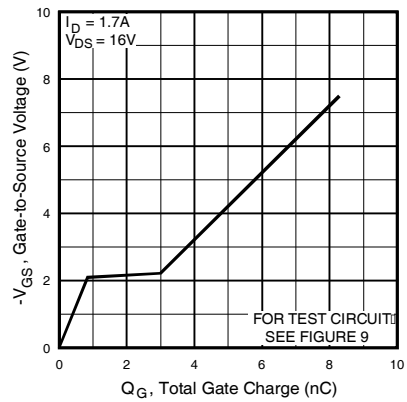
**Fig 7.** Typical On-Resistance Vs. Gate Voltage



**Fig 8.** Maximum Safe Operating Area

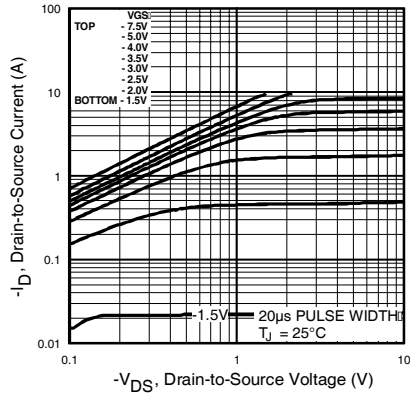


**Fig 9.** Typical Capacitance Vs. Drain-to-Source Voltage

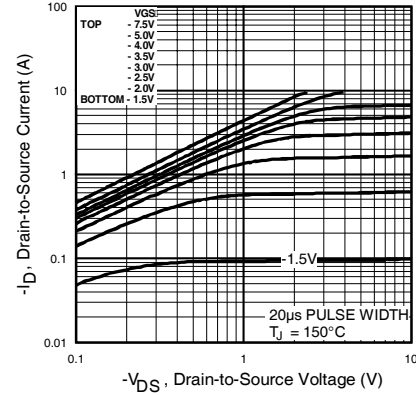


**Fig 10.** Typical Gate Charge Vs. Gate-to-Source Voltage

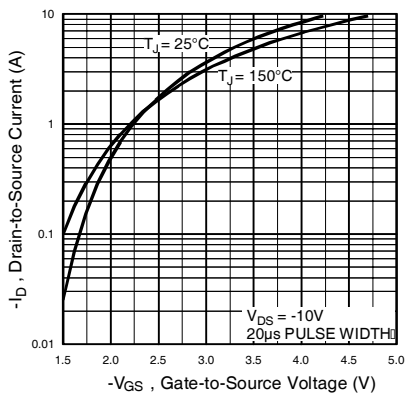
P - Channel



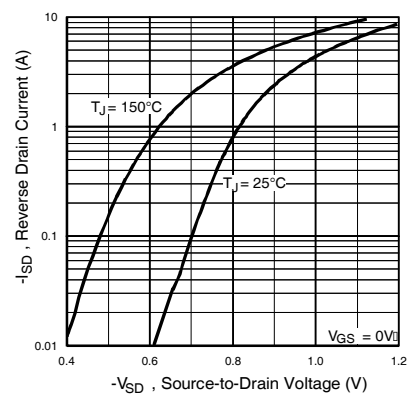
**Fig 11.** Typical Output Characteristics



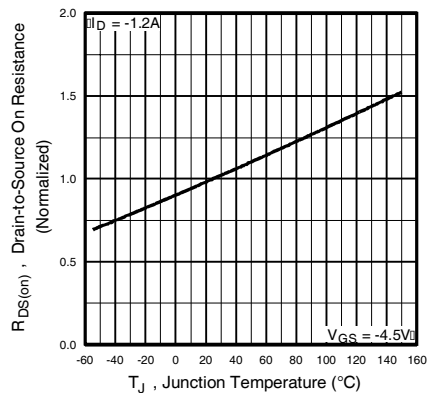
**Fig 12.** Typical Output Characteristics



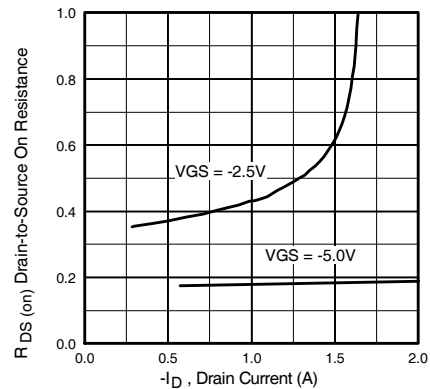
**Fig 13.** Typical Transfer Characteristics



**Fig 14.** Typical Source-Drain Diode Forward Voltage



**Fig 15.** Normalized On-Resistance Vs. Temperature

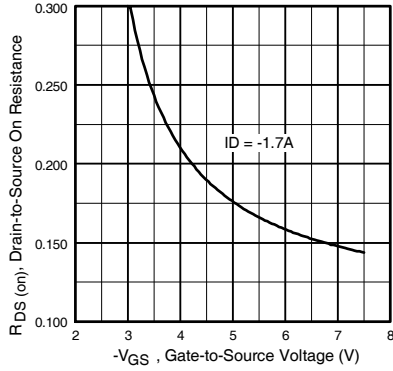


**Fig 16.** Typical On-Resistance Vs. Drain Current

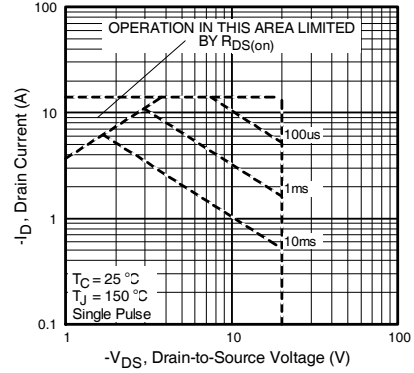
# IRF7507PbF

International  
**IR** Rectifier

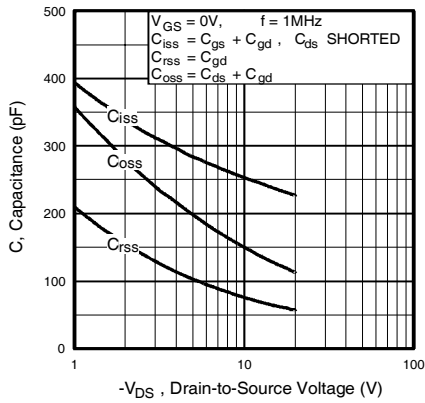
P - Channel



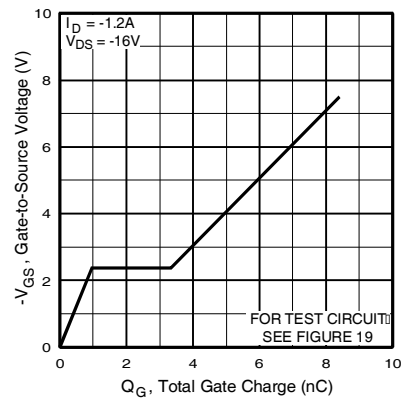
**Fig 17.** Typical On-Resistance Vs. Gate Voltage



**Fig 18.** Maximum Safe Operating Area

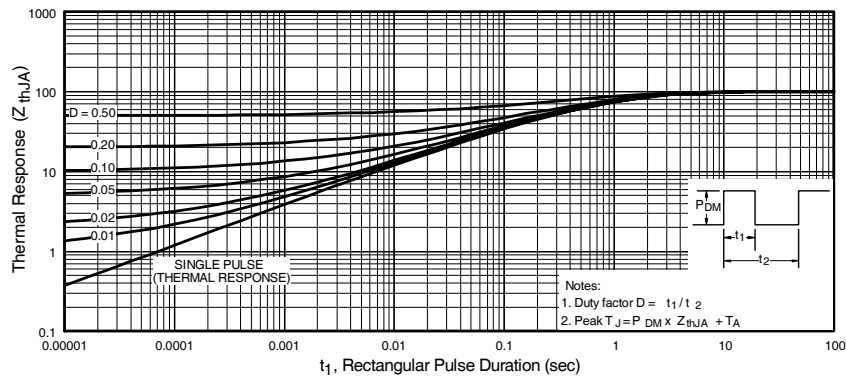


**Fig 19.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 20.** Typical Gate Charge Vs. Gate-to-Source Voltage

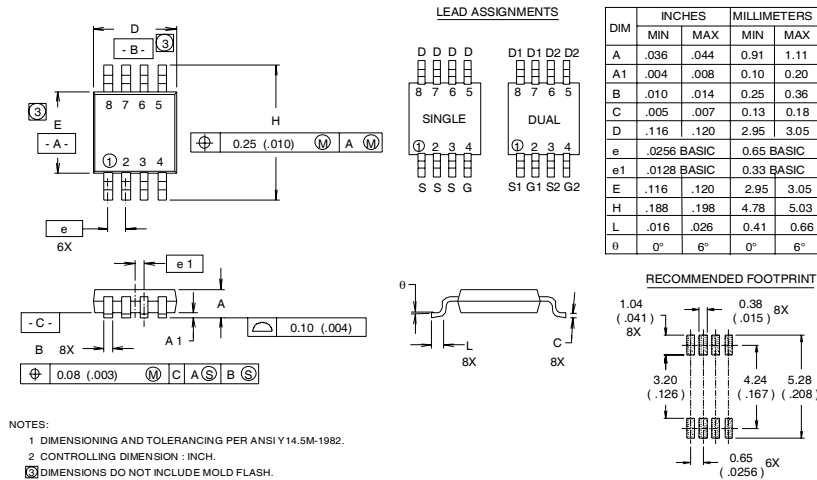
N-P - Channel



**Fig 21.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

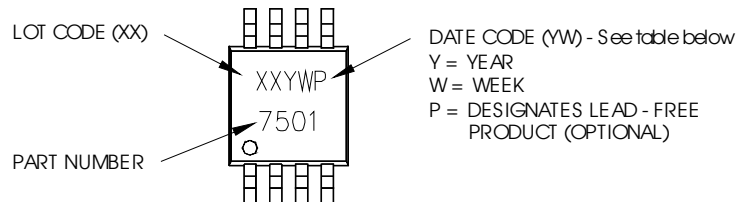
## Micro8 Package Outline

Dimensions are shown in millimeters (inches)



## Micro8 Part Marking Information

EXAMPLE: THIS IS AN IRF7501



WW = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR

YEAR	Y	WORK WEEK	W
2001	1	01	A
2002	2	02	B
2003	3	03	C
2004	4	04	D
2005	5		
2006	6		
2007	7		
2008	8		
2009	9		
2010	0	24	X
		25	Y
		26	Z

WW = (27-52) IF PRECEDED BY A LETTER

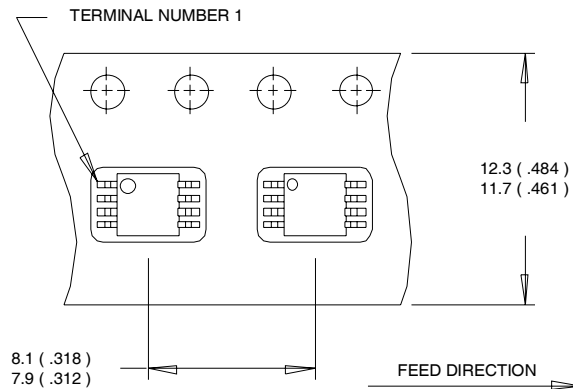
YEAR	Y	WORK WEEK	W
2001	A	27	A
2002	B	28	B
2003	C	29	C
2004	D	30	D
2005	E		
2006	F		
2007	G		
2008	H		
2009	J		
2010	K	50	X
		51	Y
		52	Z

# IRF7507PbF

## Micro8 Tape & Reel Information

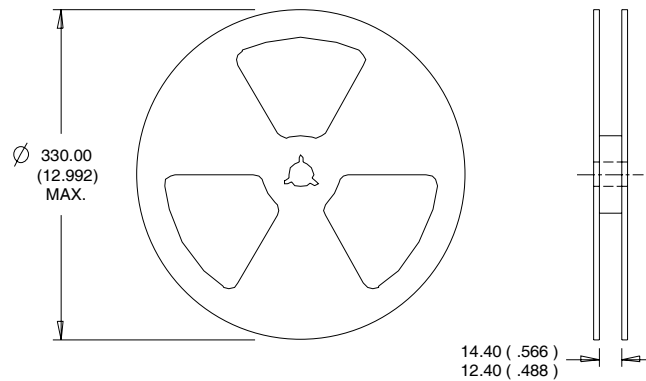
Dimensions are shown in millimeters (inches)

International  
**IR** Rectifier



### NOTES:

1. OUTLINE CONFORMS TO EIA-481 & EIA-541.
2. CONTROLLING DIMENSION : MILLIMETER.



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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TAC Fax: (310) 252-7903

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